Search Notes

Application/Control N .	Applicant(s)/Patent under Reexamination
10/679,650	TANAKA ET AL.
Examiner	**Art Unit**
Tom V. Sheng	2629

SEARCHED			
Class	Subclass	Date	Examiner
345	156	6/9/06	TS
715	863		
600	300		
(with text search)			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Consulted Raymond Bayerl GAU 2173	6/6/06	TS
Alexander Eisen 2629	6/12/06	TS
EAST Search See printout	6/5 - 6/9/06	TS
Inventor Search See printout	6/12/06	TS